

Notice of References Cited	Application/Control No. 10/805,900	Applicant(s)/Patent Under Reexamination FALAHEE, MARK H.	
	Examiner John Kim	Art Unit 3733	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,730,744	03-1998	Justin et al.	606/73
*	B	US-2004/0049279	03-2004	Sevrain, Lionel C.	623/017.13
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	K	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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